## NSN 6625-01-085-8037

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View Online at https://aerobasegroup.com/nsn/6625-01-085-8037 Width: 10.000 inches Ac Voltage Rating: 115.0 volts Frequency Rating: 60.0 hertz **Major Components:** Tester, solid state; test probes and cables Depth: 11.250 inches **Electrical Power Source Relationship:** Alternate operating **Internal Battery Accommodation:** Not included **Material And Location:** Plastic housing **Inclosure Feature:** Single item w/housing **Test Type For Which Designed:** Comparitor function, circuit boards with integrated circuits or hybrid circuits; in-circuit testing at low, medium and high impedance; circuit testing for current-limited circuit protection; in-circuit test of solid state components; reliable testing of electrolytic capacitors **Operating Test Capability:** Visual scope display projecting images indicating condition of a device under test Phase: Single Height: 3.375 inches **Surface Treatment: Plastic Surface Treatment: Plastic** Shelf Life: N/a **Unit Of Measure: Demilitarization:** No Fiig: T228-a